Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
(barcode)	10/750,013	SCHMIDT ET AL.
	Examiner	Art Unit	
	Chun-Kuan (Mike) Lee	2181	

SEARCHED

Class	Subclass	Date	Examiner
710	29	12/13/2005	CHUN-KUAN Lee
710	52-53	12/13/2005	
710	55	12/13/2005	
710	60	12/13/2005	✓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
serial and FIFO and buffer$2 and pointer$2 and (detect$4 or monitor$4) and flag$2 and elastic	12/13/2005	CHUN-KUAN Lee
serial and (FIFO same pointer$2) and (detect$4 or monitor$4) and elastic	12/13/2005	
serial and (FIFO) and (detect$4 or monitor$4) and elastic and ((skip$4 or jump$2) same pointer$2)	12/13/2005	
fifo$2 and pointer$2 and overflow$3 and underflow and ((drop$4 or skip$4) same overflow$3)	12/13/2005	
FIFO$2 and (((detect$4 or monitor$4)) same flag$2)	12/13/2005	✓